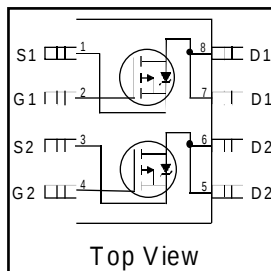


- Generation V Technology
- Ultra Low On-Resistance
- Dual P-Channel MOSFET
- Surface Mount
- Fully Avalanche Rated



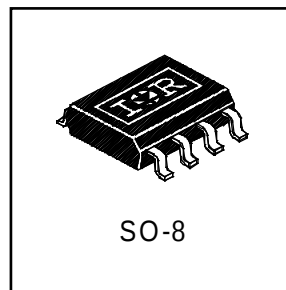
$$V_{DS} = -30V$$

$$R_{DS(on)} = 0.058\Omega$$

## Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The SO-8 has been modified through a customized leadframe for enhanced thermal characteristics and multiple-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infra red, or wave soldering techniques.



SO-8

## Absolute Maximum Ratings ( $T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

|                                              | Symbol                   | Maximum      | Units            |
|----------------------------------------------|--------------------------|--------------|------------------|
| Drain-Source Voltage                         | $V_{DS}$                 | -30          | V                |
| Gate-Source Voltage                          | $V_{GS}$                 | $\pm 20$     |                  |
| Continuous Drain Current ⑤                   | $T_A = 25^\circ\text{C}$ | -4.9         | A                |
|                                              | $T_A = 70^\circ\text{C}$ | -3.9         |                  |
| Pulsed Drain Current                         | $I_{DM}$                 | -30          |                  |
| Continuous Source Current (Diode Conduction) | $I_S$                    | -2.5         |                  |
| Maximum Power Dissipation ⑤                  | $T_A = 25^\circ\text{C}$ | 2.0          | W                |
|                                              | $T_A = 70^\circ\text{C}$ | 1.3          |                  |
| Single Pulse Avalanche Energy                | $E_{AS}$                 | 140          | mJ               |
| Avalanche Current                            | $I_{AR}$                 | -2.8         | A                |
| Repetitive Avalanche Energy                  | $E_{AR}$                 | 0.20         | mJ               |
| Peak Diode Recovery $dv/dt$ ③                | $dv/dt$                  | -5.0         | V/ ns            |
| Junction and Storage Temperature Range       | $T_J, T_{STG}$           | -55 to + 150 | $^\circ\text{C}$ |

## Thermal Resistance Ratings

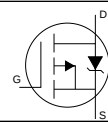
| Parameter                     | Symbol          | Limit | Units              |
|-------------------------------|-----------------|-------|--------------------|
| Maximum Junction-to-Ambient ⑤ | $R_{\theta JA}$ | 62.5  | $^\circ\text{C/W}$ |

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ.  | Max.  | Units               | Conditions                                                 |
|---------------------------------|--------------------------------------|------|-------|-------|---------------------|------------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | -30  | —     | —     | V                   | $V_{GS} = 0V$ , $I_D = -250\mu A$                          |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.022 | —     | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D = -1mA$             |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | 0.042 | 0.058 | $\Omega$            | $V_{GS} = -10V$ , $I_D = -4.9A$ ④                          |
|                                 |                                      | —    | 0.076 | 0.098 |                     | $V_{GS} = -4.5V$ , $I_D = -3.6A$ ④                         |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | -1.0 | —     | —     | V                   | $V_{DS} = V_{GS}$ , $I_D = -250\mu A$                      |
| $g_{fs}$                        | Forward Transconductance             | —    | 7.7   | —     | S                   | $V_{DS} = -15V$ , $I_D = -4.9A$                            |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —     | -1.0  | $\mu A$             | $V_{DS} = -24V$ , $V_{GS} = 0V$                            |
|                                 |                                      | —    | —     | -25   |                     | $V_{DS} = -24V$ , $V_{GS} = 0V$ , $T_J = 55^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —     | 100   | nA                  | $V_{GS} = -20V$                                            |
|                                 | Gate-to-Source Reverse Leakage       | —    | —     | -100  |                     | $V_{GS} = 20V$                                             |
| $Q_g$                           | Total Gate Charge                    | —    | 23    | 34    | nC                  | $I_D = -4.9A$                                              |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | 3.8   | 5.7   |                     | $V_{DS} = -15V$                                            |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | 5.9   | 8.9   |                     | $V_{GS} = -10V$ , See Fig. 10 ④                            |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 13    | 19    | ns                  | $V_{DD} = -15V$                                            |
| $t_r$                           | Rise Time                            | —    | 13    | 20    |                     | $I_D = -1.0A$                                              |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 34    | 51    |                     | $R_G = 6.0\Omega$                                          |
| $t_f$                           | Fall Time                            | —    | 32    | 48    |                     | $R_D = 15\Omega$ ④                                         |
| $C_{iss}$                       | Input Capacitance                    | —    | 710   | —     | pF                  | $V_{GS} = 0V$                                              |
| $C_{oss}$                       | Output Capacitance                   | —    | 380   | —     |                     | $V_{DS} = -25V$                                            |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 180   | —     |                     | $f = 1.0MHz$ , See Fig. 5                                  |

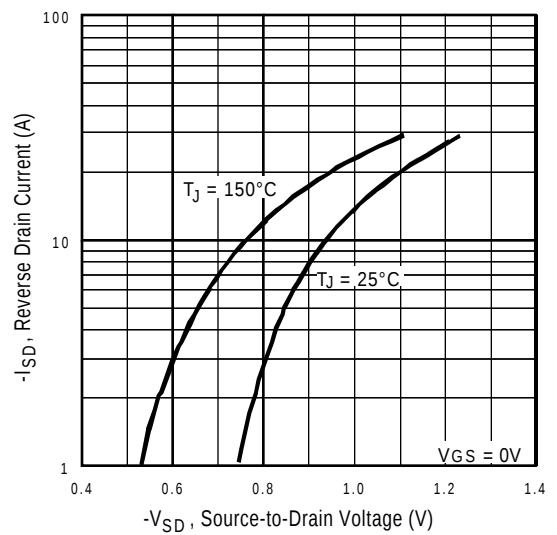
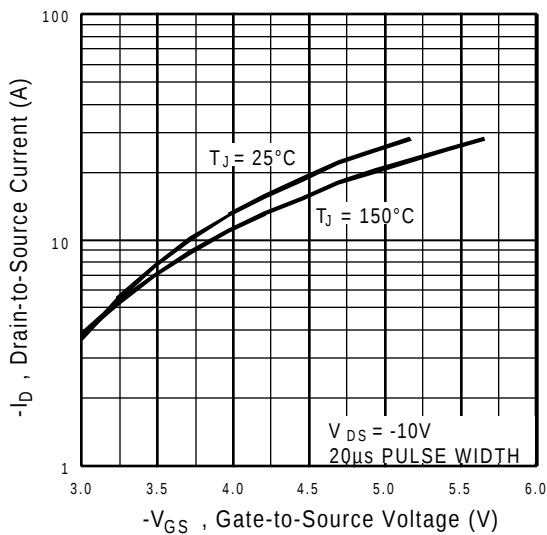
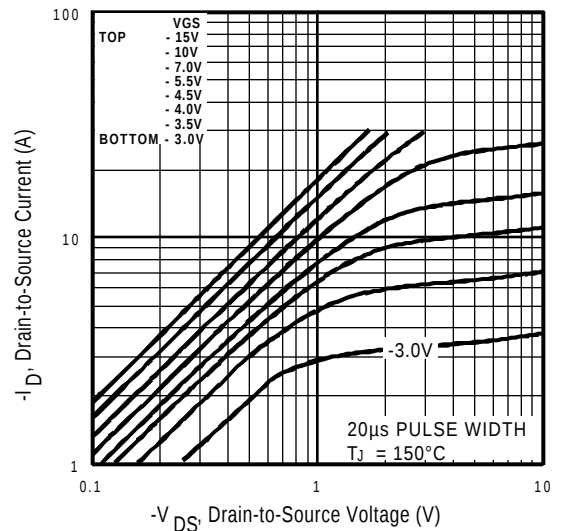
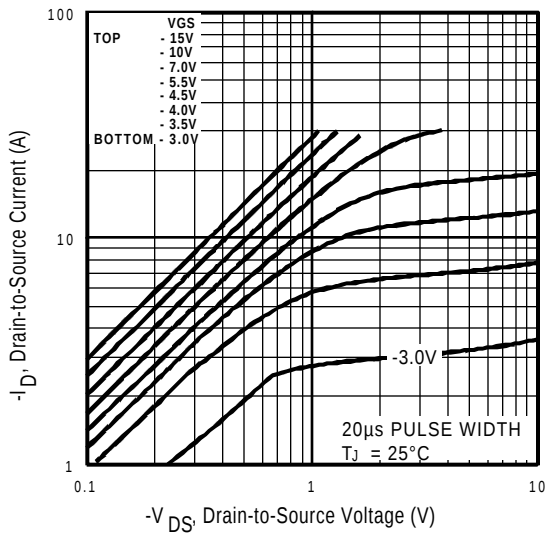
## Source-Drain Ratings and Characteristics

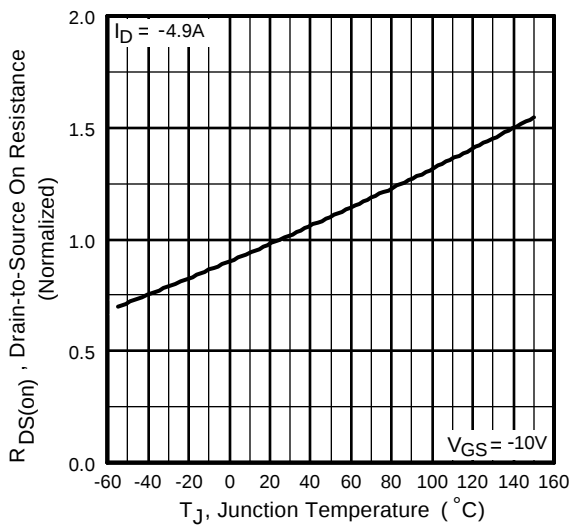
|          | Parameter                              | Min. | Typ.  | Max. | Units | Conditions                                                     |
|----------|----------------------------------------|------|-------|------|-------|----------------------------------------------------------------|
| $I_S$    | Continuous Source Current (Body Diode) | —    | —     | -2.5 | A     | MOSFET symbol showing the integral reverse p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —    | —     | -30  |       |                                                                |
| $V_{SD}$ | Diode Forward Voltage                  | —    | -0.78 | -1.0 | V     | $T_J = 25^\circ\text{C}$ , $I_S = -1.7A$ , $V_{GS} = 0V$ ③     |
| $t_{rr}$ | Reverse Recovery Time                  | —    | 44    | 66   | ns    | $T_J = 25^\circ\text{C}$ , $I_F = -1.7A$                       |
| $Q_{rr}$ | Reverse Recovery Charge                | —    | 42    | 63   | nC    | $di/dt = 100A/\mu s$ ③                                         |



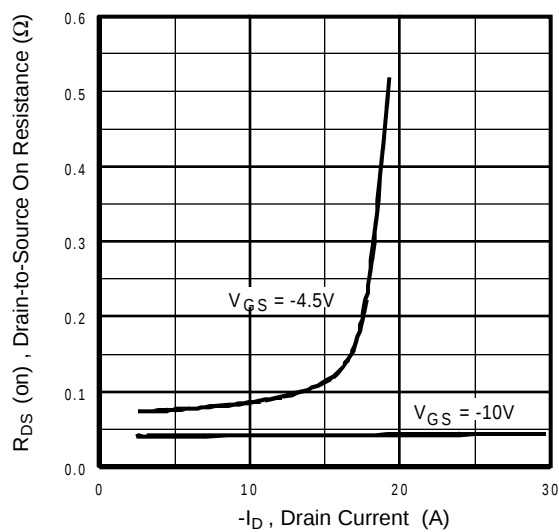
### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 35mH$   
 $R_G = 25\Omega$ ,  $I_{AS} = -2.8A$ .
- ③  $I_{SD} \leq -2.8A$ ,  $di/dt \leq 150A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  
 $T_J \leq 150^\circ\text{C}$
- ④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .
- ⑤ Surface mounted on FR-4 board,  $t \leq 10sec$ .

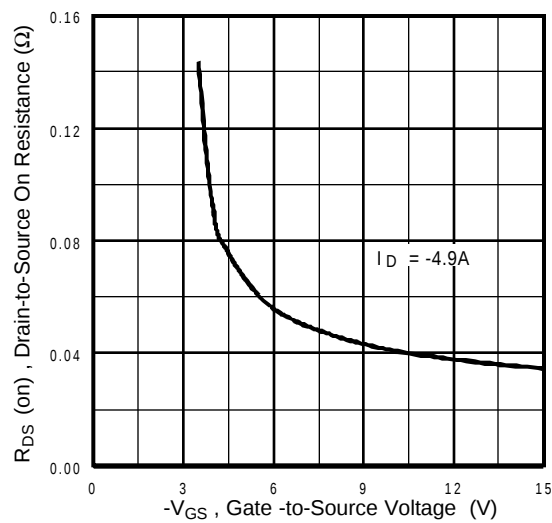




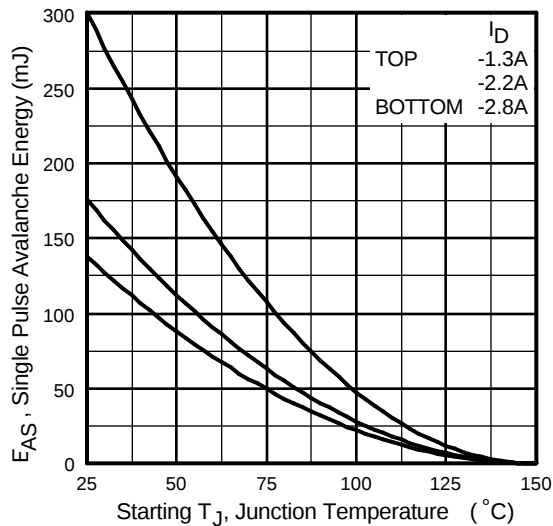
**Fig 5.** Normalized On-Resistance Vs. Temperature



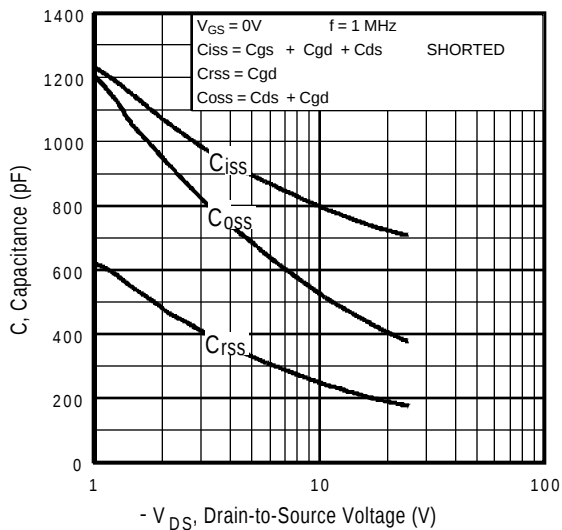
**Fig 6.** Typical On-Resistance Vs. Drain Current



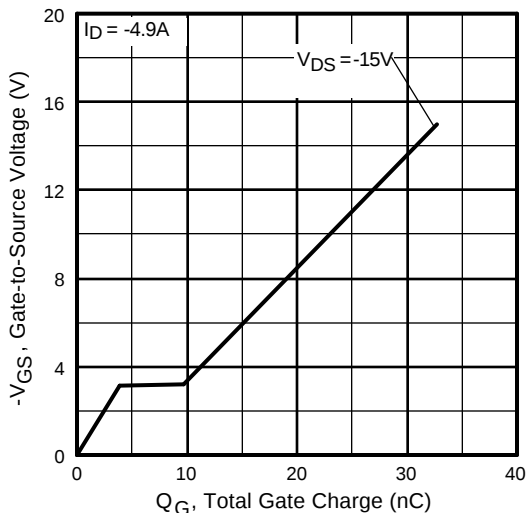
**Fig 7.** Typical On-Resistance Vs. Gate Voltage



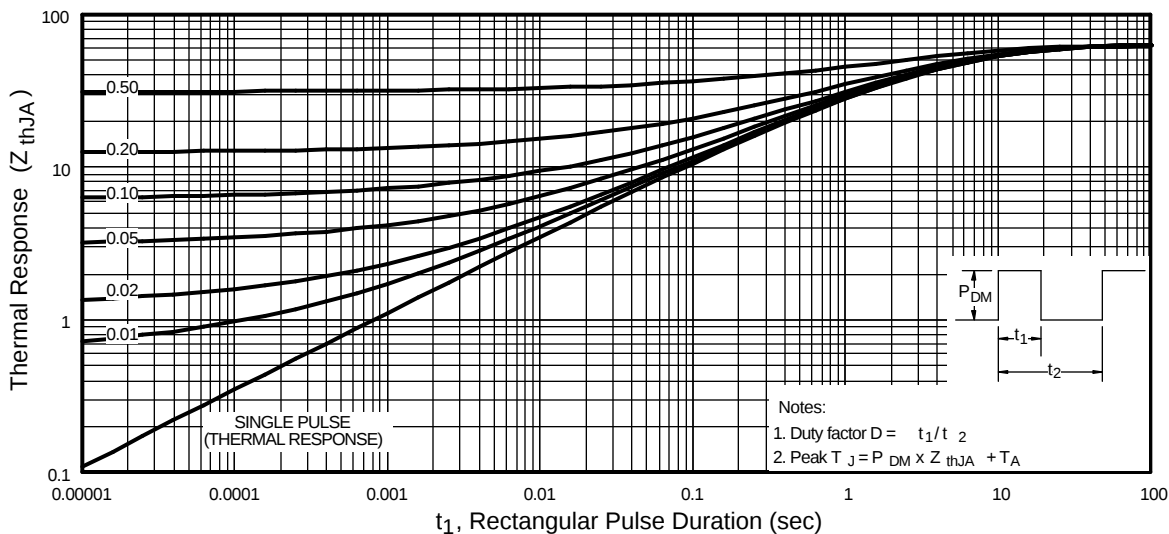
**Fig 8.** Maximum Avalanche Energy Vs. Drain Current



**Fig 9.** Typical Capacitance Vs. Drain-to-Source Voltage



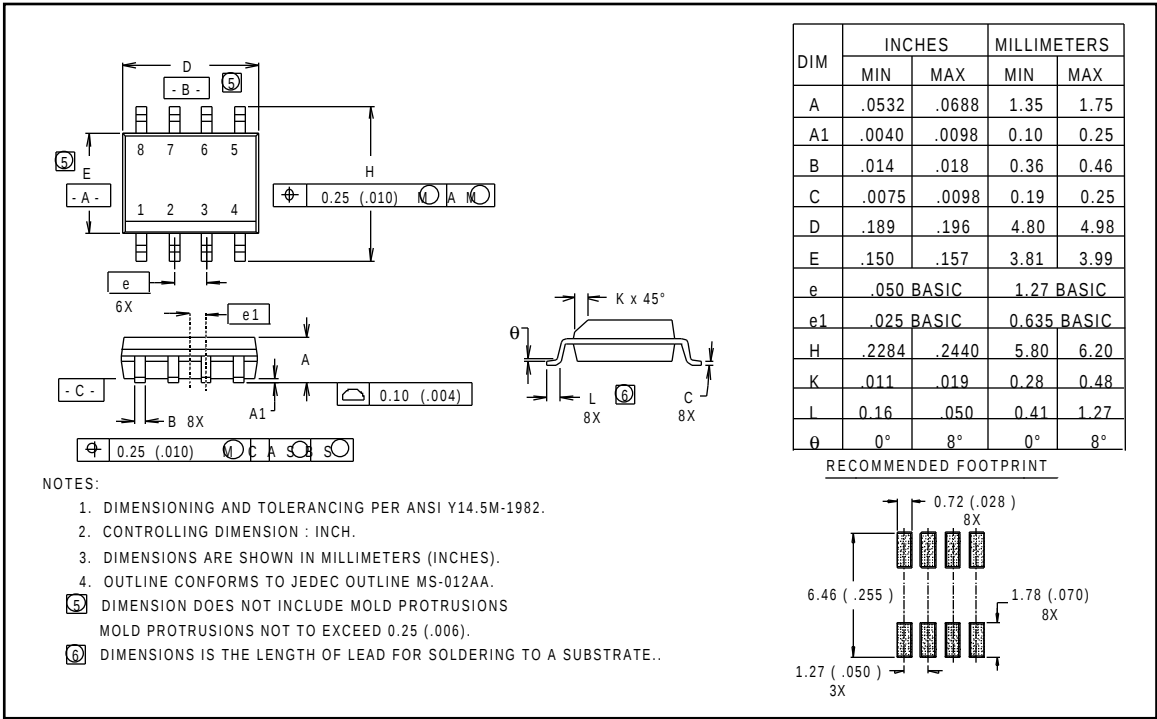
**Fig 10.** Typical Gate Charge Vs. Gate-to-Source Voltage



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

Package Outline

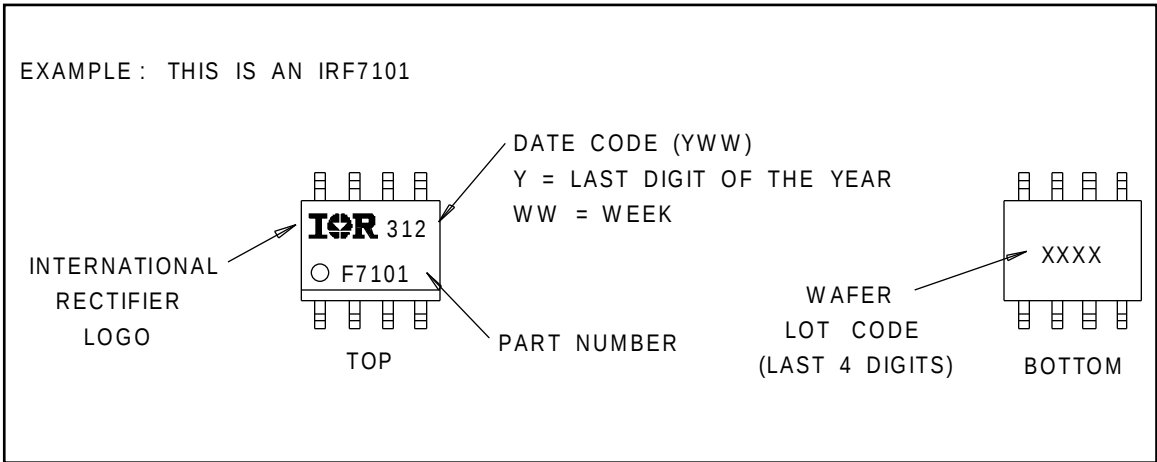
SO8 Outline



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1982.
  2. CONTROLLING DIMENSION : INCH.
  3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
  4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
  5. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS  
MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.006).
  6. DIMENSIONS IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE..

Part Marking Information

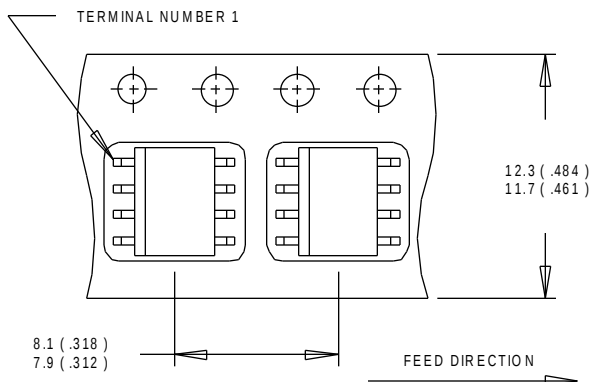
SO8



## Tape & Reel Information

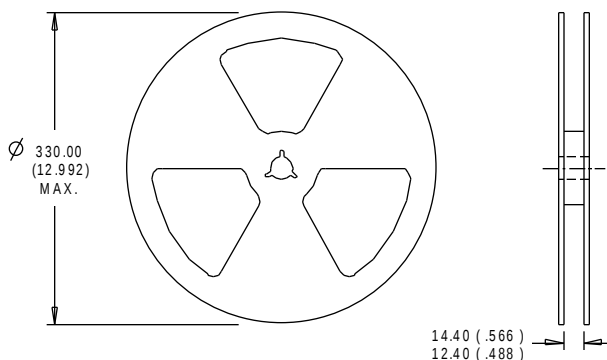
**S08**

Dimensions are shown in millimeters (inches)



**NOTES:**

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



**NOTES:**

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

International  
**IR** Rectifier

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**IR ITALY:** Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111

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